



128K X 8 BIT LOW POWER CMOS SRAM

FEATURES

- Access time :55ns
- Low power consumption:
Operating current:10 mA (TYP.)
Standby current: 1 μ A (TYP)
- Single 2.7V ~ 5.5V power supply
- Fully Compatible with all Competitors 5V product
- Fully Compatible with all Competitors 3.3V product

- Fully static operation
- Tri-state output
- Data retention voltage : 1.5V (MIN.)
- All products are ROHS Compliant
- Package : 32-pin 450 mil SOP
32-pin 600 mil P-DIP
32-pin 8mm x 20mm TSOP-I
32-pin 8mm x 13.4mm sTSOP
36-ball 6mm x 8mm TFBGA

GENERAL DESCRIPTION

The AS6C1008 is a 1,048,576-bit low power CMOS static random access memory organized as 131,072 words by 8 bits. It is fabricated using very high performance, high reliability CMOS technology. Its standby current is stable within the range of operating temperature.

The AS6C1008 is well designed for very low power system applications, and particularly well suited for battery back-up non-volatile memory application.

The AS6C1008 operates from a single power supply of 2.7V ~ 5.5V.

FUNCTIONAL BLOCK DIAGRAM



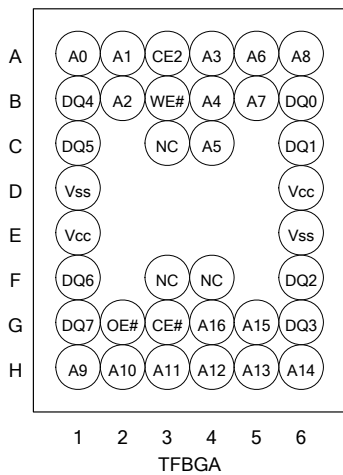
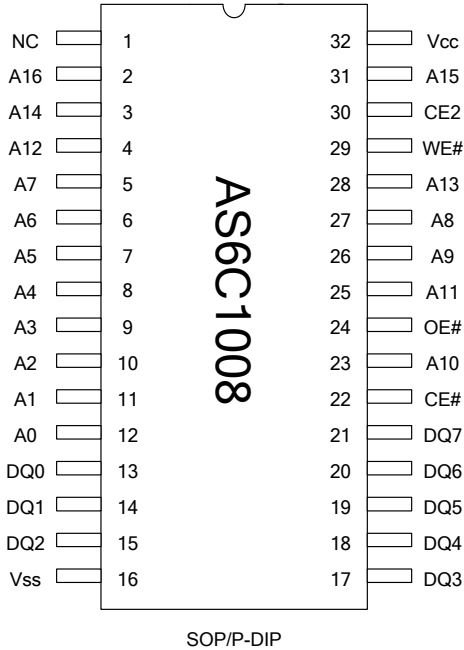
PIN DESCRIPTION

| SYMBOL | DESCRIPTION |
|-----------|---------------------|
| A0 - A16 | Address Inputs |
| DQ0 - DQ7 | Data Inputs/Outputs |
| CE#, CE2 | Chip Enable Inputs |
| WE# | Write Enable Input |
| OE# | Output Enable Input |
| Vcc | Power Supply |
| Vss | Ground |
| NC | No Connection |



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PIN CONFIGURATION





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ABSOLUTE MAXIMUM RATINGS*

| PARAMETER | SYMBOL | RATING | UNIT |
|--|---------------------|--------------------|------|
| Terminal Voltage with Respect to V _{SS} | V _{TERM} | -0.5 to 7.0 | V |
| Operating Temperature | T _A | 0 to 70(C grade) | °C |
| | | -40 to 85(I grade) | |
| Storage Temperature | T _{STG} | -65 to 150 | °C |
| Power Dissipation | P _D | 1 | W |
| DC Output Current | I _{OUT} | 50 | mA |
| Soldering Temperature (under 10 sec) | T _{SOLDER} | 260 | °C |

*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect device reliability.

TRUTH TABLE

| MODE | CE# | CE2 | OE# | WE# | I/O OPERATION | SUPPLY CURRENT |
|----------------|-----|-----|-----|-----|------------------|------------------------------------|
| Standby | H | X | X | X | High-Z | I _{SB1} |
| | X | L | X | X | High-Z | I _{SB1} |
| Output Disable | L | H | H | H | High-Z | I _{CC} , I _{CC1} |
| Read | L | H | L | H | D _{OUT} | I _{CC} , I _{CC1} |
| Write | L | H | X | L | D _{IN} | I _{CC} , I _{CC1} |

Note: H = V_{IH}, L = V_{IL}, X = Don't care.

DC ELECTRICAL CHARACTERISTICS

| PARAMETER | SYMBOL | TEST CONDITION | MIN. | TYP. ⁴ | MAX. | UNIT |
|--|------------------------------|--|---------------------|-------------------|----------------------|------|
| Supply Voltage | V _{CC} | | 2.7 | 3.0 | 5.5 | V |
| Input High Voltage | V _{IH} ¹ | | 0.7*V _{CC} | - | V _{CC} +0.3 | V |
| Input Low Voltage | V _{IL} ² | | -0.2 | - | 0.6 | V |
| Input Leakage Current | I _{LI} | V _{CC} ≥ V _{IN} ≥ V _{SS} | -1 | - | 1 | μA |
| Output Leakage Current | I _{LO} | V _{CC} ≥ V _{OUT} ≥ V _{SS} , Output Disabled | -1 | - | 1 | μA |
| Output High Voltage | V _{OH} | I _{OH} = -1mA | 2.2 | 2.7 | - | V |
| Output Low Voltage | V _{OL} | I _{OL} = 2mA | - | - | 0.4 | V |
| Average Operating Power supply Current | I _{CC} | Cycle time = Min. CE# = V _{IL} and CE2 = V _{IH} , I _{I/O} = 0mA | -55 | 10 | 60 | mA |
| | I _{CC1} | Cycle time = 1μs CE# ≤ 0.2V and CE2 ≥ V _{CC} -0.2V, I _{I/O} = 0mA other pins at 0.2V or V _{CC} -0.2V | - | 1 | 10 | mA |
| Standby Power Supply Current | I _{SB1} | CE# ≥ V _{CC} -0.2V | C* | 1 | 20 | μA |
| | | or CE2 ≤ 0.2V | I* | 1 | 50 | μA |

*C=Commercial temperature/I= Industrial temperature



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Notes:

1. $V_{IH(max)} = V_{CC} + 3.0V$ for pulse width less than 10ns.
2. $V_{IL(min)} = V_{SS} - 3.0V$ for pulse width less than 10ns.
3. Over/Undershoot specifications are characterized, not 100% tested.
4. Typical values are included for reference only and are not guaranteed or tested.
Typical values are measured at $V_{CC} = V_{CC(TYP.)}$ and $T_A = 25^\circ C$

CAPACITANCE ($T_A = 25^\circ C, f = 1.0MHz$)

| PARAMETER | SYMBOL | MIN. | MAX | UNIT |
|--------------------------|-----------|------|-----|------|
| Input Capacitance | C_{IN} | - | 6 | pF |
| Input/Output Capacitance | $C_{I/O}$ | - | 8 | pF |

Note : These parameters are guaranteed by device characterization, but not production tested.

AC TEST CONDITIONS

| | |
|--|---|
| Input Pulse Levels | 0.2V to $V_{CC} - 0.2V$ |
| Input Rise and Fall Times | 3ns |
| Input and Output Timing Reference Levels | 1.5V |
| Output Load | $C_L = 30pF + 1TTL, I_{OH}/I_{OL} = -1mA/2mA$ |

AC ELECTRICAL CHARACTERISTICS

(1) READ CYCLE

| PARAMETER | SYM. | AS6C1008-55 | | UNIT |
|------------------------------------|-------------|-------------|------|------|
| | | MIN. | MAX. | |
| Read Cycle Time | t_{RC} | 55 | - | ns |
| Address Access Time | t_{AA} | - | 55 | ns |
| Chip Enable Access Time | t_{ACE} | - | 55 | ns |
| Output Enable Access Time | t_{OE} | - | 30 | ns |
| Chip Enable to Output in Low-Z | t_{CLZ}^* | 10 | - | ns |
| Output Enable to Output in Low-Z | t_{OLZ}^* | 5 | - | ns |
| Chip Disable to Output in High-Z | t_{CHZ}^* | - | 20 | ns |
| Output Disable to Output in High-Z | t_{OHZ}^* | - | 20 | ns |
| Output Hold from Address Change | t_{OH} | 10 | - | ns |

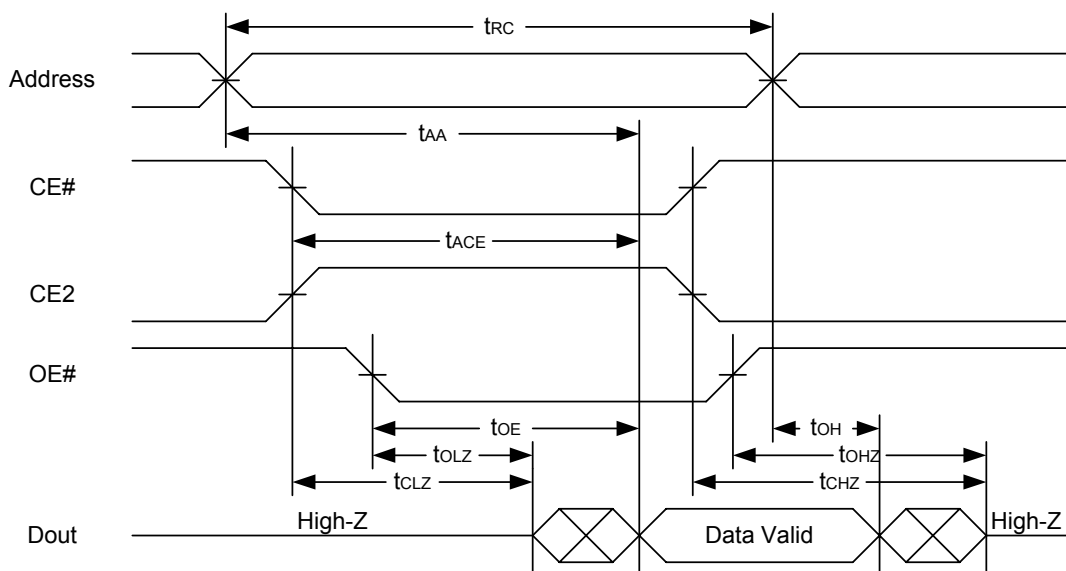
(2) WRITE CYCLE

| PARAMETER | SYM. | AS6C1008-55 | | UNIT |
|----------------------------------|-------------|-------------|------|------|
| | | MIN. | MAX. | |
| Write Cycle Time | t_{WC} | 55 | - | ns |
| Address Valid to End of Write | t_{AW} | 50 | - | ns |
| Chip Enable to End of Write | t_{CW} | 50 | - | ns |
| Address Set-up Time | t_{AS} | 0 | - | ns |
| Write Pulse Width | t_{WP} | 45 | - | ns |
| Write Recovery Time | t_{WR} | 0 | - | ns |
| Data to Write Time Overlap | t_{DW} | 25 | - | ns |
| Data Hold from End of Write Time | t_{DH} | 0 | - | ns |
| Output Active from End of Write | t_{OW}^* | 5 | - | ns |
| Write to Output in High-Z | t_{WHZ}^* | - | 20 | ns |

*These parameters are guaranteed by device characterization, but not production tested.



128K X 8 BIT LOW POWER CMOS SRAM

TIMING WAVEFORMS**READ CYCLE 1 (Address Controlled) (1,2)****READ CYCLE 2 (CE# and CE2 and OE# Controlled) (1,3,4,5)**

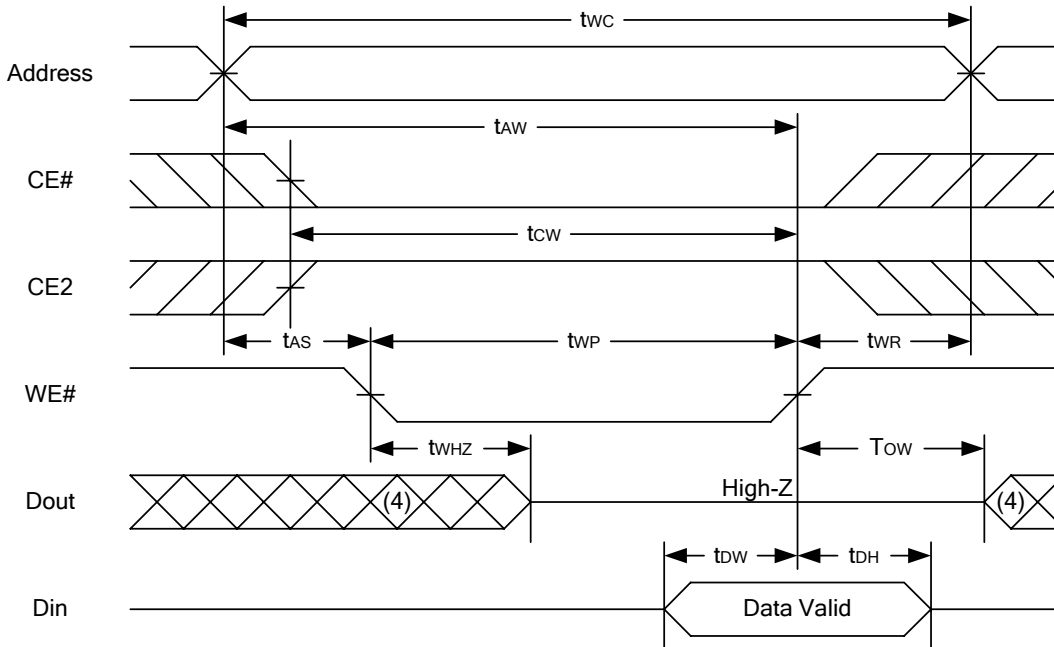
Notes :

1. WE# is high for read cycle.
2. Device is continuously selected OE# = low, CE# = low, CE2 = high.
3. Address must be valid prior to or coincident with CE# = low, CE2 = high; otherwise t_{AA} is the limiting parameter.
4. t_{CLZ} , t_{OLZ} , t_{CHZ} and t_{OHZ} are specified with $C_L = 5\text{pF}$. Transition is measured $\pm 500\text{mV}$ from steady state.
5. At any given temperature and voltage condition, t_{CHZ} is less than t_{CLZ} , t_{OHZ} is less than t_{OLZ} .

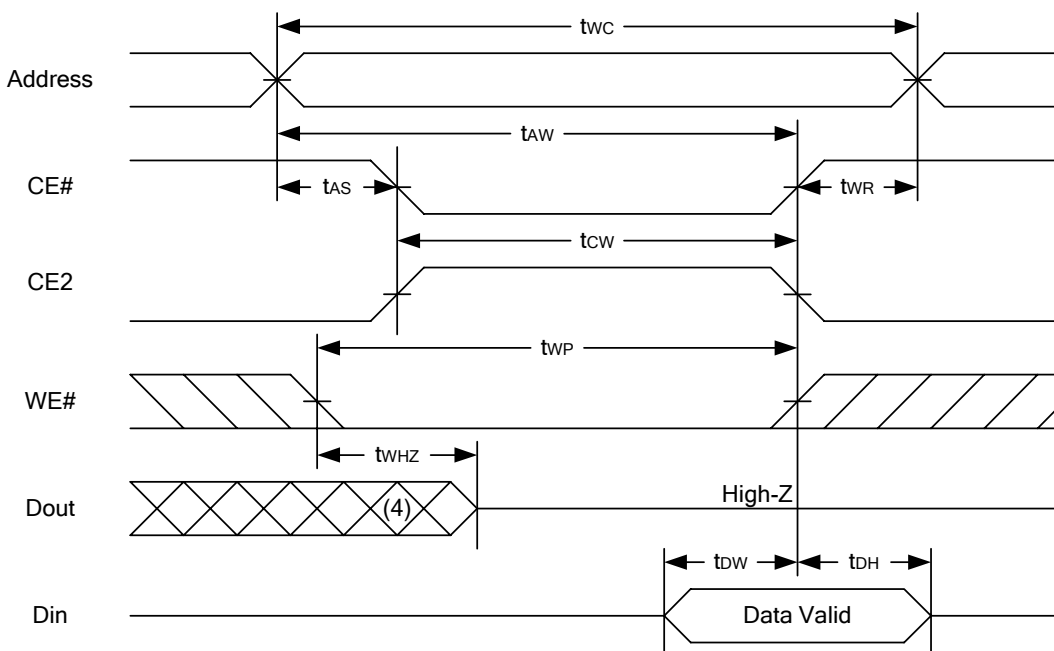


128K X 8 BIT LOW POWER CMOS SRAM

WRITE CYCLE 1 (WE# Controlled) (1,2,3,5,6)



WRITE CYCLE 2 (CE# and CE2 Controlled) (1,2,5,6)



Notes :

1. WE#, CE# must be high or CE2 must be low during all address transitions.
2. A write occurs during the overlap of a low CE#, high CE2, low WE#.
3. During a WE#-controlled write cycle with OE# low, twp must be greater than twhz + tdw to allow the drivers to turn off and data to be placed on the bus.
4. During this period, I/O pins are in the output state, and input signals must not be applied.
5. If the CE# low transition and CE2 high transition occurs simultaneously with or after WE# low transition, the outputs remain in a high impedance state.
6. tow and twhz are specified with CL = 5pF. Transition is measured ±500mV from steady state.



128K X 8 BIT LOW POWER CMOS SRAM

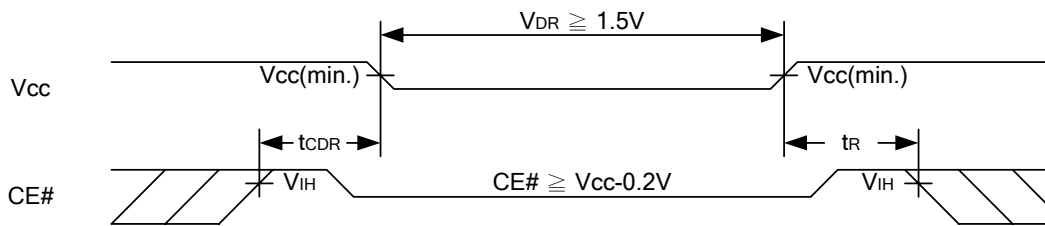
DATA RETENTION CHARACTERISTICS

| PARAMETER | SYMBOL | TEST CONDITION | MIN. | TYP. | MAX. | UNIT | |
|-------------------------------------|------------------|---|------------------|------|------|------|----|
| Vcc for Data Retention | V _{DR} | CE# ≥ V _{CC} - 0.2V or CE2 ≤ 0.2V | 1.5 | - | 5.5 | V | |
| Data Retention Current | I _{DR} | V _{CC} = 1.5V CE# ≥ V _{CC} - 0.2V or CE2 ≤ 0.2V | C** | - | 0.5 | 12 | μA |
| | | | I** | | 0 | 30 | μA |
| Chip Disable to Data Retention Time | t _{CDR} | See Data Retention Waveforms (below) | 0 | - | - | ns | |
| Recovery Time | t _R | | t _{RC*} | - | - | ns | |

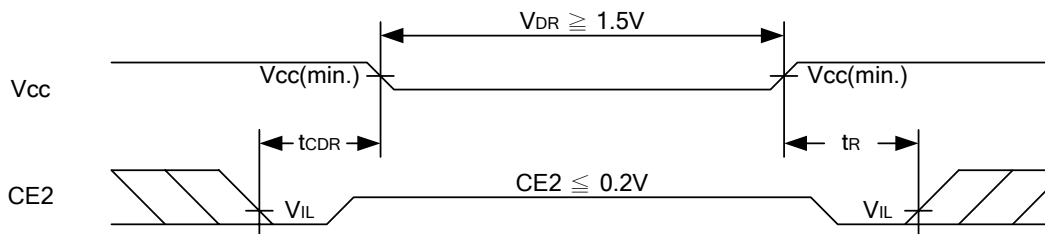
t_{RC*} = Read Cycle Time C=Commercial temp/I = Industrial temp**

DATA RETENTION WAVEFORM

Low Vcc Data Retention Waveform (1) (CE# controlled)



Low Vcc Data Retention Waveform (2) (CE2 controlled)

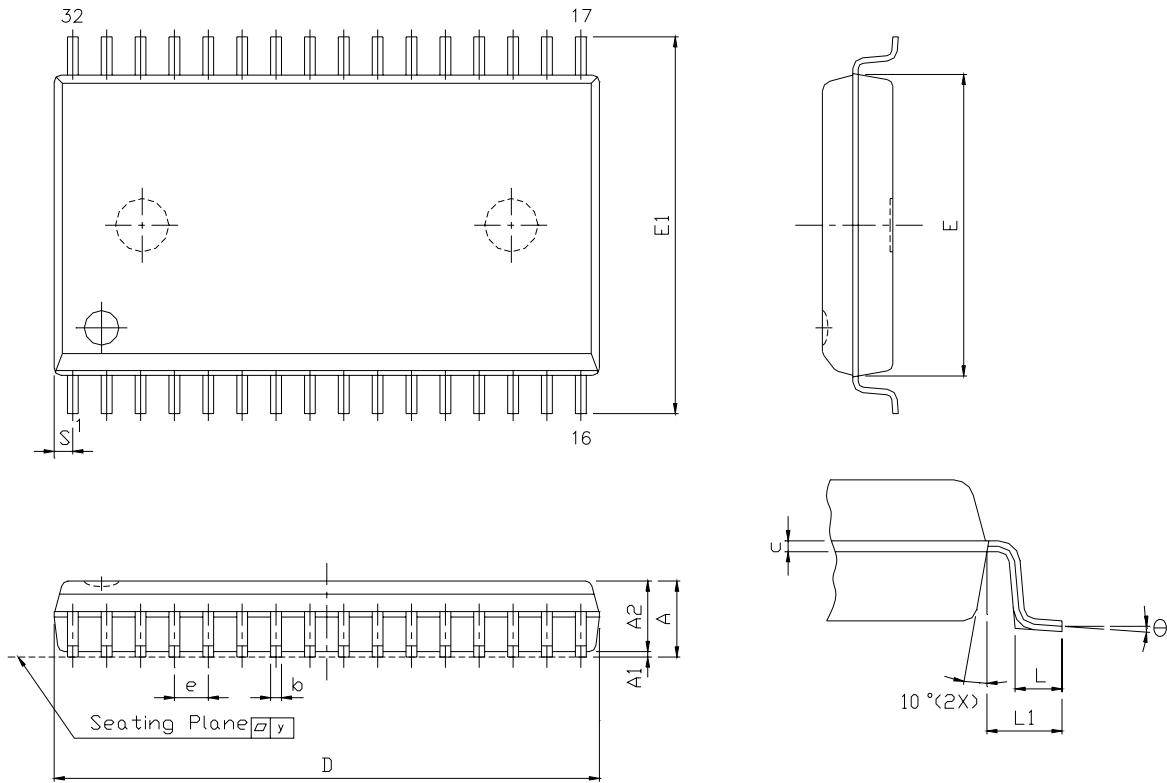




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PACKAGE OUTLINE DIMENSION

32 pin 450 mil SOP Package Outline Dimension



| SYM. | UNIT | INCH.(BASE) | MM(REF) |
|------|------|---------------|---------------|
| A | | 0.118 (MAX) | 2.997 (MAX) |
| A1 | | 0.004(MIN) | 0.102(MIN) |
| A2 | | 0.111(MAX) | 2.82(MAX) |
| b | | 0.016(TYP) | 0.406(TYP) |
| c | | 0.008(TYP) | 0.203(TYP) |
| D | | 0.817(MAX) | 20.75(MAX) |
| E | | 0.445 ±0.005 | 11.303 ±0.127 |
| E1 | | 0.555 ±0.012 | 14.097 ±0.305 |
| e | | 0.050(TYP) | 1.270(TYP) |
| L | | 0.0347 ±0.008 | 0.881 ±0.203 |
| L1 | | 0.055 ±0.008 | 1.397 ±0.203 |
| S | | 0.026(MAX) | 0.660 (MAX) |
| y | | 0.004(MAX) | 0.101(MAX) |
| θ | | 0° -10° | 0° -10° |



128K X 8 BIT LOW POWER CMOS SRAM

32 pin 600 mil P-DIP Package Outline Dimension



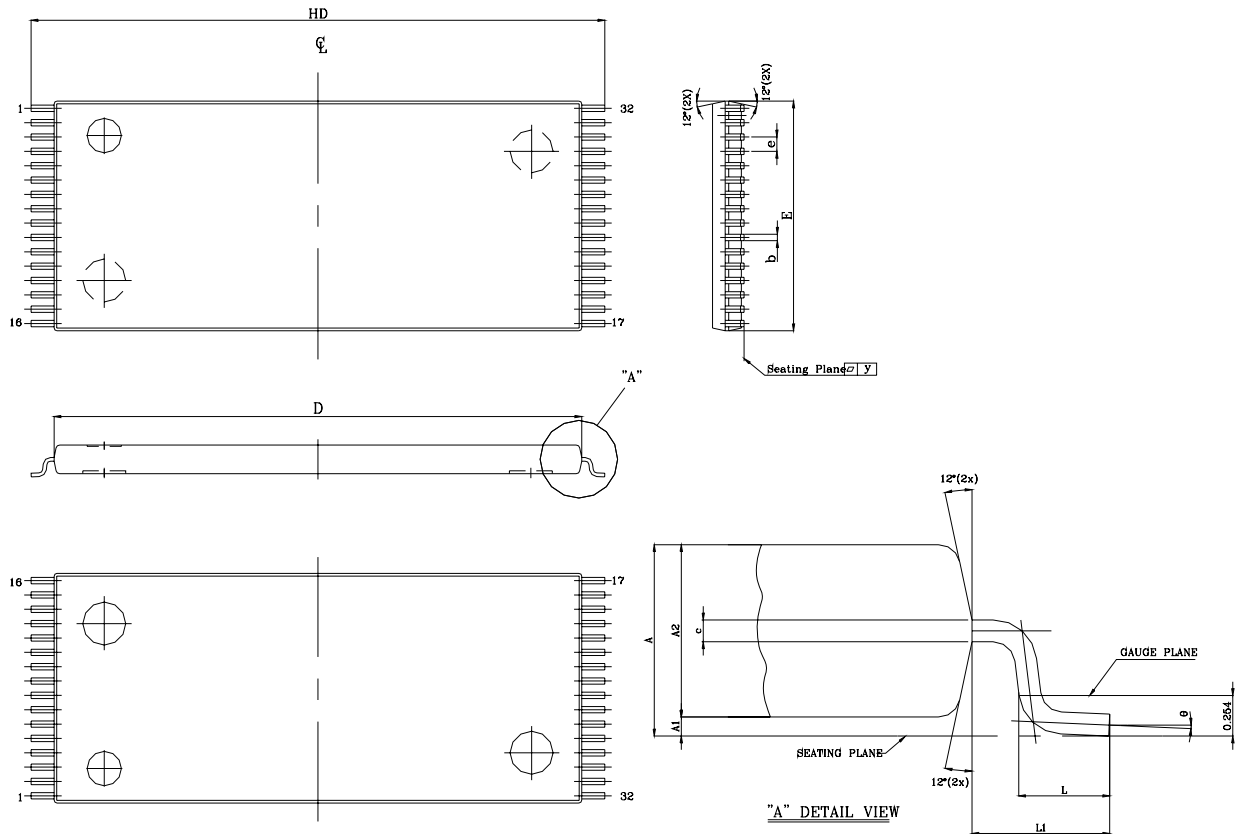
| SYM. \ UNIT | INCH(BASE) | MM(REF) |
|-------------|---------------|-----------------|
| A1 | 0.001 (MIN) | 0.254 (MIN) |
| A2 | 0.150 ± 0.005 | 3.810 ± 0.127 |
| B | 0.018 ± 0.005 | 0.457 ± 0.127 |
| D | 1.650 ± 0.005 | 41.910 ± 0.127 |
| E | 0.600 ± 0.010 | 15.240 ± 0.254 |
| E1 | 0.544 ± 0.004 | 13.818 ± 0.102 |
| e | 0.100 (TYP) | 2.540 (TYP) |
| eB | 0.640 ± 0.020 | 16.256 ± 0.508. |
| L | 0.130 ± 0.010 | 3.302 ± 0.254 |
| S | 0.075 ± 0.010 | 1.905 ± 0.254 |
| Q1 | 0.070 ± 0.005 | 1.778 ± 0.127 |

Note : D/E1/S dimension do not include mold flash.



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32 pin 8mm x 20mm TSOP-I Package Outline Dimension

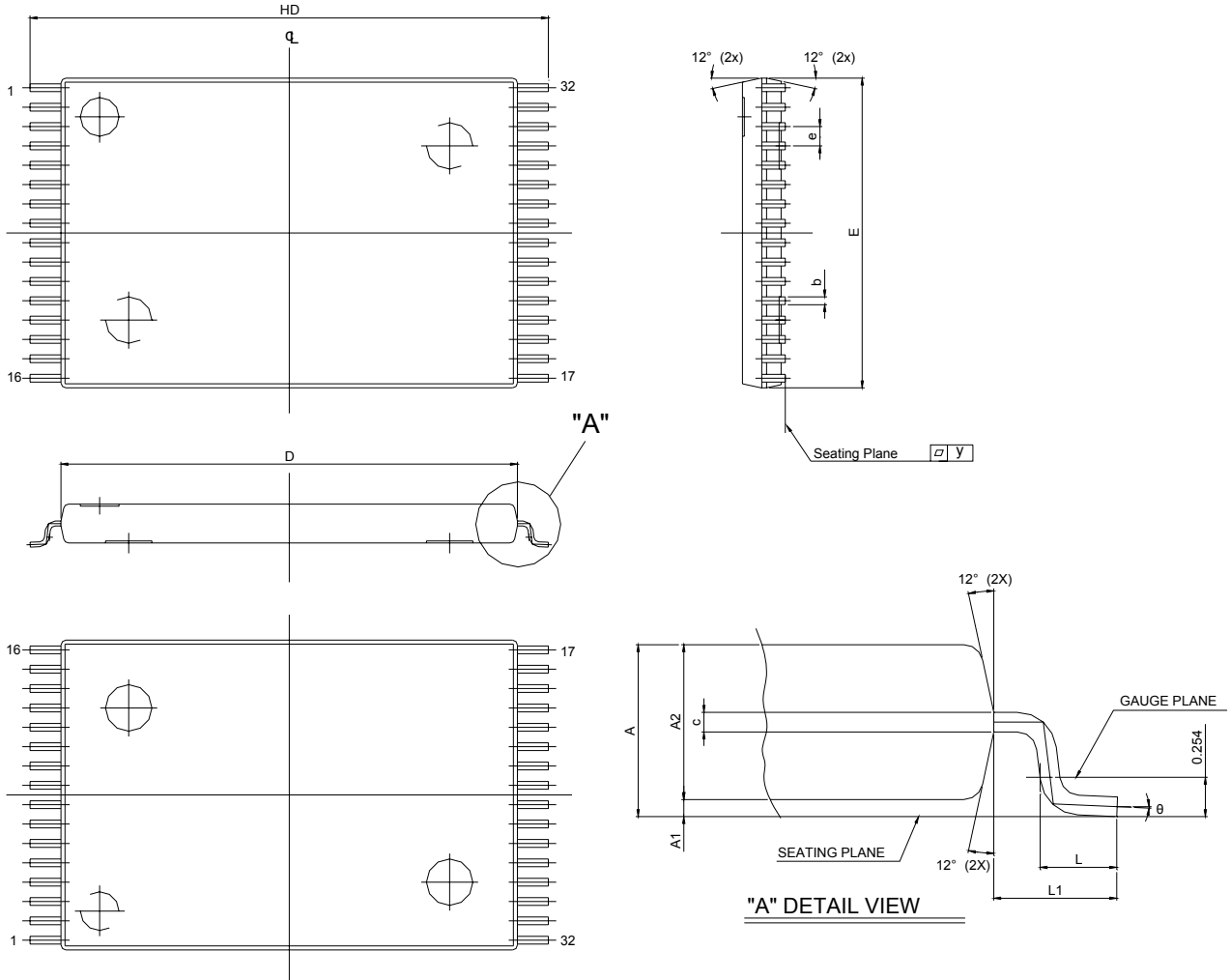


| SYM. | UNIT | INCH(BASE) | MM(REF) |
|------|------|--------------------------|-----------------------|
| A | | 0.047 (MAX) | 1.20 (MAX) |
| A1 | | 0.004 ±0.002 | 0.10 ±0.05 |
| A2 | | 0.039 ±0.002 | 1.00 ±0.05 |
| b | | 0.008 + 0.002 - 0.001 | 0.20 + 0.05 - 0.03 |
| c | | 0.005 (TYP) | 0.127 (TYP) |
| D | | 0.724 ±0.004 | 18.40 ±0.10 |
| E | | 0.315 ±0.004 | 8.00 ±0.10 |
| e | | 0.020 (TYP) | 0.50 (TYP) |
| HD | | 0.787 ±0.008 | 20.00 ±0.20 |
| L | | 0.0197 ±0.004 | 0.50 ±0.10 |
| L1 | | 0.0315 ±0.004 | 0.08 ±0.10 |
| y | | 0.003 (MAX) | 0.076 (MAX) |
| θ | | 0° ~ 5° | 0° ~ 5° |



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32 pin 8mm x 13.4mm sTSSOP Package Outline Dimension



| SYM. | UNIT | INCH(BASE) | MM(REF) |
|------|------|---------------|--------------|
| A | | 0.049 (MAX) | 1.25 (MAX) |
| A1 | | 0.005 ±0.002 | 0.130 ±0.05 |
| A2 | | 0.039 ±0.002 | 1.00 ±0.05 |
| b | | 0.008 ±0.01 | 0.20±0.025 |
| c | | 0.005 (TYP) | 0.127 (TYP) |
| D | | 0.465 ±0.004 | 11.80 ±0.10 |
| E | | 0.315 ±0.004 | 8.00 ±0.10 |
| e | | 0.020 (TYP) | 0.50 (TYP) |
| HD | | 0.528±0.008 | 13.40 ±0.20. |
| L | | 0.0197 ±0.004 | 0.50 ±0.10 |
| L1 | | 0.0315 ±0.004 | 0.8 ±0.10 |
| y | | 0.003 (MAX) | 0.076 (MAX) |
| θ | | 0°~5° | 0°~5° |



128K X 8 BIT LOW POWER CMOS SRAM

ORDERING INFORMATION

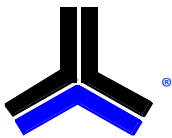
Ordering Codes

| Alliance | Organization | VCC range | Package | Operating Temp | Speed ns |
|-----------------|--------------|-----------|---------------------------|--------------------------------|----------|
| AS6C1008-55PCN | 128K X 8 | 2.7-5.5V | 32pin 600mil PDIP | Commercial ~ 0° C to 70° C | 55 |
| AS6C1008-55PIN | 128K X 8 | 2.7-5.5V | 32pin 600mil PDIP | Industrial ~ -40°C to 85° C | 55 |
| AS6C1008-55SIN | 128K X 8 | 2.7-5.5V | 32pin 450mil SOP | Industrial ~ -40°C to 85° C | 55 |
| AS6C1008-55TIN | 128K X 8 | 2.7-5.5V | 32pin TSOP-I (8 x 20 mm) | Industrial ~ -40°C to 85° C | 55 |
| AS6C1008-55STIN | 128K X 8 | 2.7-5.5V | 32pin sTSOP (8 x 13.4 mm) | Industrial ~ -40°C to 85° C | 55 |
| AS6C1008-55BIN | 128K X 8 | 2.7-5.5V | 36pin TFBGA (6mm x 8mm) | Industrial ~ -40°C to 85° C | 55 |

Part numbering system

| AS6C | 1008 | - 55 | X | X | N |
|--------------------------------|--|----------------|---|---|--|
| low power SRAM prefix | Device Number 10 = 1M 08 = by 8 | Access Time | Package Options: P = 32 pin 600 mil P-DIP S = 32 pin 450 mil SOP T = 32 pin TSOP-I (8mm x 20 mm) ST = 32 pin sTSOP (8 x 13.4 mm) B = 36 ball 6 x 8mm TFBGA | Temperature Range: C = Commercial (0°C to +70° C) I = Industrial (-40° to +85° C) | N = Lead Free ROHS Compliant Part |

128K X 8 BIT LOW POWER CMOS SRAM



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- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
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- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
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JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

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